

PCN# : P63EAAB

Issue Date : May. 04, 2016

DESIGN/PROCESS CHANGE NOTIFICATION

This is to inform you that a change is being made to the products listed below.

Unless otherwise indicated in the details of this notification, the identified change will have no impact on product quality, reliability, electrical, visual or mechanical performance and affected products will remain fully compliant to all published specifications. Products incorporating this change may be shipped interchangeably with existing unchanged products.

This change is planned to take effect in 90 calendar days from the date of this notification. Please work with your local Fairchild Sales Representative to manage your inventory of unchanged product if your evaluation of this change will require more than 90 calendar days.

Please contact your local Customer Quality Engineer within 30 days of receipt of this notification if you require any additional data or samples.

Implementation of change:

Expected First Shipment Date for Changed Product : Aug. 02, 2016

Expected First Date Code of Changed Product :1632

Description of Change (From):

LSOP products are classified at Moisture Sensitivity Level 1 (MSL 1). No dry pack for LSOP with MSL 1.

Description of Change (To):

Re-classification of Moisture Sensitivity Level for LSOP products to Level 3. Packing template to include dry pack for LSOP MSL 3.

Reason for Change:

Moisture Sensitivity Level (MSL) rating re-classification according to product's capability and assembly from Philippines subcontractor.



Affected Product(s):

| FSL206MRL | FSQ0165RLX | FSQ0265RLX |
|------------|------------|------------|
| FSQ0365RLX | FSQ0370RLA | FSQ321L |
| FSQ321LX | | |

| Qualification Plan | Device | Package | Process | No. of Lots |
|--------------------|------------|--------------|--------------|-------------|
| Q20140067 | FSQ0370RLA | ATEC - 8LSOP | SDG4 / Q-FET | 1 |

| Test Description: | Condition: | Standard : | Duration: | Results: |
|--------------------------------------|-----------------------|-------------|-----------|----------|
| MSL3 Precondition | 260°C, 3 cycles | JESD22-A113 | - | 0/231 |
| High Temperature Reverse Bias | 125C, 560V | JESD22-A108 | 1000 hrs | 0/77 |
| High Temperature Operating Life test | 125C, 22V/50V/560V | JESD22-A108 | 1000 hrs | 0/77 |
| High Accelerate Stressed Test | 130C, 85%RH, 22V/100V | JESD22-A101 | 96 hrs | 0/77 |
| High Temperature Storage Test | 150C | JESD22-A103 | 1000 hrs | 0/77 |
| Temperature Cycle | -65C, 150C | JESD22-A104 | 500сус | 0/77 |

| Qualification Plan | Device | Package | Process | No. of Lots |
|--------------------|-----------|--------------|-------------------|-------------|
| Q20140067 | FSL136HRL | ATEC - 8LSOP | FS50D2D / UNI-FET | 1 |

| Test Description: | Condition: | Standard : | Duration: | Results: |
|--------------------------------------|-----------------------|-------------|-----------|----------|
| MSL3 Precondition | 260°C, 3 cycles | JESD22-A113 | - | 0/231 |
| High Temperature Reverse Bias | 125C, 520V | JESD22-A108 | 1000 hrs | 0/77 |
| High Temperature Operating Life test | 125C, 26V/50V/520V | JESD22-A108 | 1000 hrs | 0/77 |
| High Accelerate Stressed Test | 130C, 85%RH, 26V/100V | JESD22-A101 | 96 hrs | 0/77 |
| High Temperature Storage Test | 150C | JESD22-A103 | 1000 hrs | 0/77 |
| Temperature Cycle | -65C, 150C | JESD22-A104 | 500сус | 0/77 |

| Qualification Plan | Device | Package | Process | No. of Lots |
|--------------------|---------|--------------|---------|-------------|
| Q20140067 | FSQ510M | ATEC - 7LSOP | SDG4D | 1 |

| Test Description: | Condition: | Standard : | Duration: | Results: |
|--------------------------------------|-------------------------|-------------|-----------|----------|
| MSL3 Precondition | 260°C, 3 cycles | JESD22-A113 | - | 0/231 |
| High Temperature Reverse Bias | 125C, 560V | JESD22-A108 | 1000 hrs | 0/77 |
| High Temperature Operating Life test | 100C, 5V/20V/50V/400V | JESD22-A108 | 1000 hrs | 0/77 |
| High Accelerate Stressed Test | 130C, 85%RH, 11V/5V/50V | JESD22-A101 | 96 hrs | 0/77 |
| High Temperature Storage Test | 150C | JESD22-A103 | 1000 hrs | 0/77 |
| Temperature Cycle | -65C, 150C | JESD22-A104 | 500cyc | 0/77 |